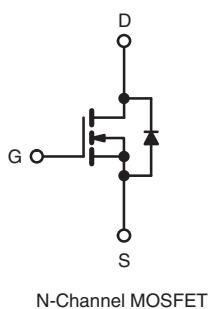


## Power MOSFET

<b>PRODUCT SUMMARY</b>	
V <sub>DS</sub> (V)	550
R <sub>DS(on)</sub> at 25 °C (Ω)	V <sub>GS</sub> = 10 V   0.43
Q <sub>g</sub> max. (nC)	160
Q <sub>gs</sub> (nC)	14
Q <sub>gd</sub> (nC)	28
Configuration	Single

### FEATURES

- Optimal Design
  - Low Area Specific On-Resistance
  - Low Input Capacitance (C<sub>iss</sub>)
  - Reduced Capacitive Switching Losses
  - High Body Diode Ruggedness
  - Avalanche Energy Rated (UIS)
- Optimal Efficiency and Operation
  - Low Cost
  - Simple Gate Drive Circuitry
  - Low Figure-of-Merit (FOM): R<sub>on</sub> x Q<sub>g</sub>
  - Fast Switching



### APPLICATIONS

- Consumer Electronics
  - Displays (LCD or Plasma TV)
- Server and Telecom Power Supplies
  - SMPS
- Industrial
  - Welding
  - Induction Heating
  - Motor Drives
- Battery Chargers
- SMPS
  - Power Factor Correction (PFC)

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V <sub>DS</sub>	550	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	
Gate-Source Voltage AC (f > 1 Hz)			30	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	I <sub>D</sub>	13	A
	T <sub>C</sub> = 25 °C		6	
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	42	
Linear Derating Factor			2.1	W/°C
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>A</sub>	242	mJ
Maximum Power Dissipation		P <sub>D</sub>	258	W
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C	dV/dt	24	V/ns
Reverse Diode dV/dt <sup>c</sup>			0.36	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	°C

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature.
- V<sub>DD</sub> = 50 V, starting T<sub>J</sub> = 25 °C, L = 10 mH, R<sub>g</sub> = 25 Ω, I<sub>AS</sub> = 7.5 A.
- 1.6 mm from case.
- I<sub>SD</sub> ≤ I<sub>D</sub>, starting T<sub>J</sub> = 25 °C.

<b>THERMAL RESISTANCE RATINGS</b>				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	40	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.45	°C/W

<b>SPECIFICATIONS</b> ( $T_J = 25$ °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ V, $I_D = 250$ μA		550	-	-	V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, $I_D = 250$ μA		-	0.56	-	V/°C
Gate-Source Threshold Voltage (N)	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250$ μA		2	-	4	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20$ V		-	-	± 100	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 500$ V, $V_{GS} = 0$ V		-	-	1	
		$V_{DS} = 400$ V, $V_{GS} = 0$ V, $T_J = 125$ °C		-	-	10	μA
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10$ V	$I_D = 10$ A	-	0.43	-	Ω
Forward Transconductance	$g_{fs}$	$V_{DS} = 50$ V, $I_D = 10$ A		-	12	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0$ V, $V_{DS} = 100$ V, $f = 1$ MHz		-	2784	-	pF
Output Capacitance	$C_{oss}$			-	152	-	
Reverse Transfer Capacitance	$C_{rss}$			-	13	-	
Effective output capacitance, energy related <sup>a</sup>	$C_{o(er)}$	$V_{GS} = 0$ V, $V_{DS} = 0$ V to 400 V		-	131	-	
Effective output capacitance, time related <sup>b</sup>	$C_{o(tr)}$			-	189	-	
Total Gate Charge	$Q_g$	$V_{GS} = 10$ V	$I_D = 10$ A, $V_{DS} = 400$ V	-	85	160	nC
Gate-Source Charge	$Q_{gs}$			-	14	-	
Gate-Drain Charge	$Q_{gd}$			-	28	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 400$ V, $I_D = 10$ A, $V_{GS} = 10$ V, $R_g = 9.1$ Ω		-	24	50	ns
Rise Time	$t_r$			-	31	62	
Turn-Off Delay Time	$t_{d(off)}$			-	117	176	
Fall Time	$t_f$			-	56	112	
Gate Input Resistance	$R_g$	$f = 1$ MHz, open drain		-	1.8	-	Ω
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1 3	A
Pulsed Diode Forward Current	$I_{SM}$			-	-	3 0	
Diode Forward Voltage	$V_{SD}$	$T_J = 25$ °C, $I_S = 10$ A, $V_{GS} = 0$ V		-	-	1.2	V
Reverse Recovery Time	$t_{rr}$	$T_J = 25$ °C, $I_F = I_S = 10$ A, $dI/dt = 100$ A/μs, $V_R = 20$ V		-	437	-	ns
Reverse Recovery Charge	$Q_{rr}$			-	5.9	-	μC
Reverse Recovery Current	$I_{RRM}$			-	25	-	A

**Notes**

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .  
b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .

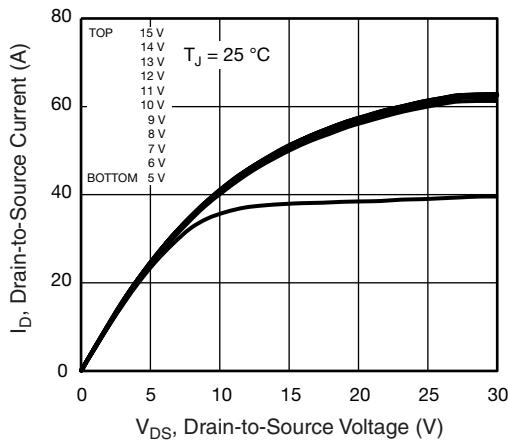
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics

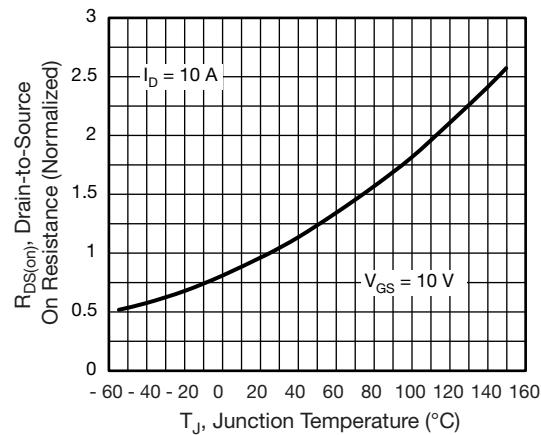


Fig. 4 - Normalized On-Resistance vs. Temperature

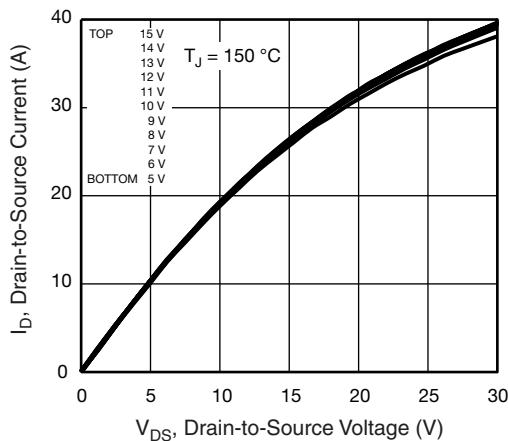


Fig. 2 - Typical Output Characteristics

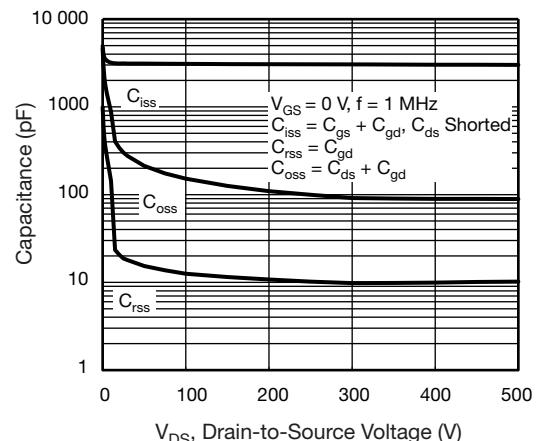


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

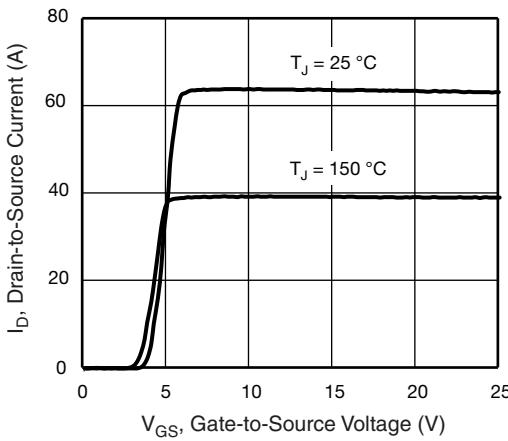


Fig. 3 - Typical Transfer Characteristics

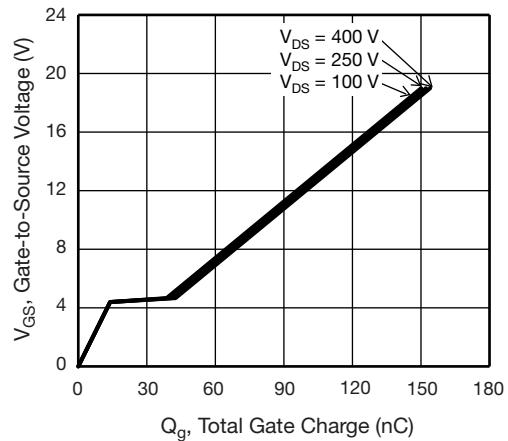


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

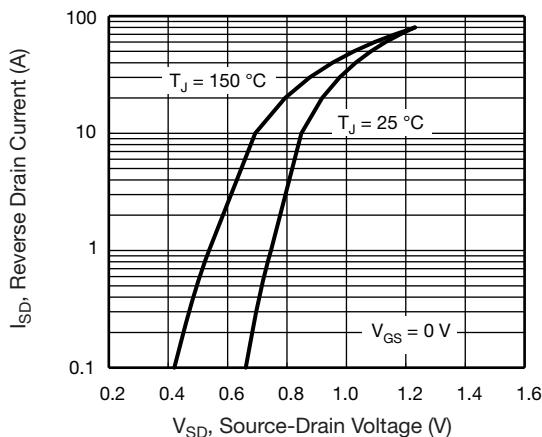


Fig. 7 - Typical Source-Drain Diode Forward Voltage

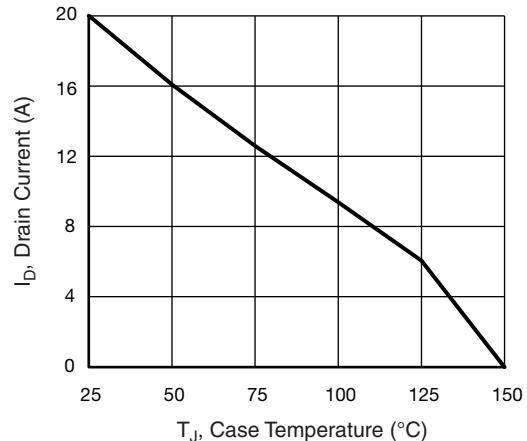


Fig. 9 - Maximum Drain Current vs. Case Temperature

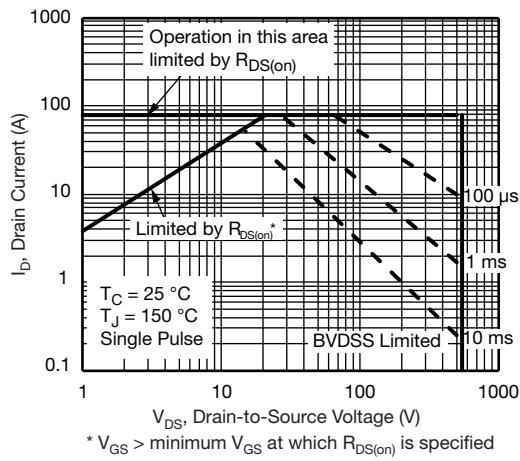


Fig. 8 - Maximum Safe Operating Area

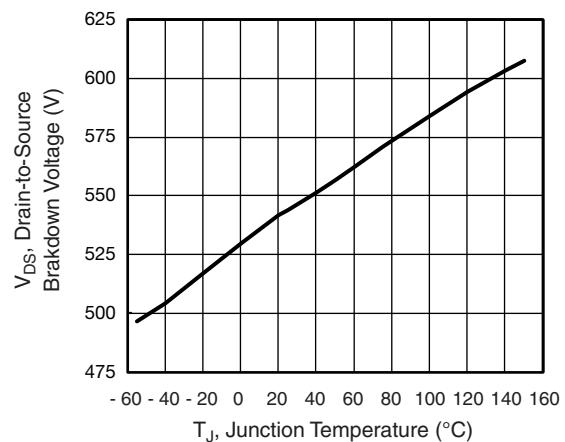


Fig. 10 - Temperature vs. Drain-to-Source Voltage

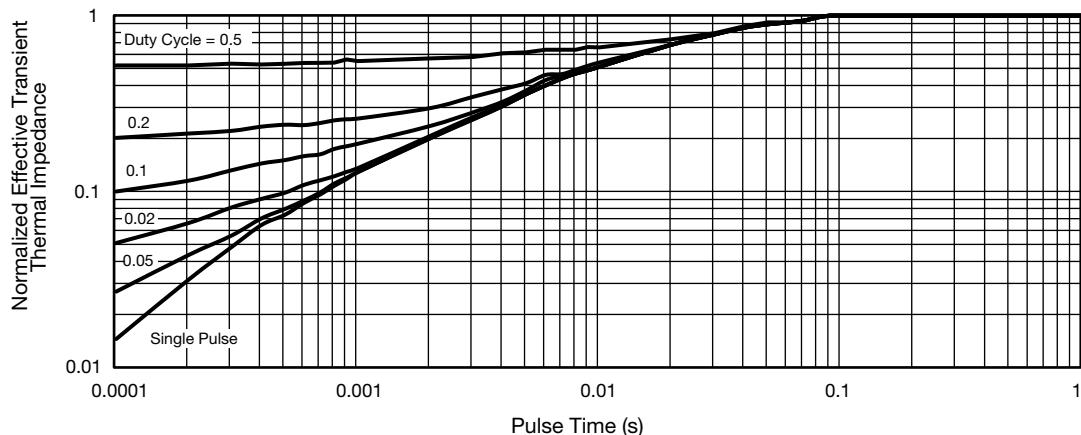


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case

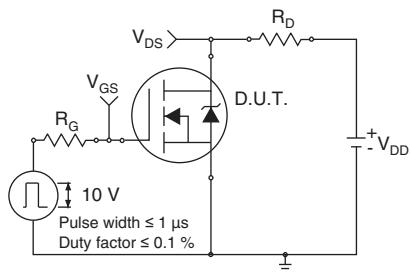


Fig. 12 - Switching Time Test Circuit

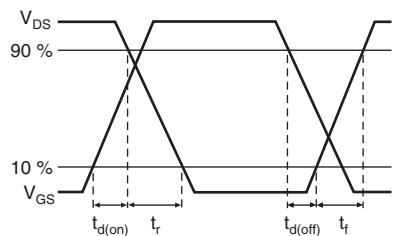


Fig. 13 - Switching Time Waveforms

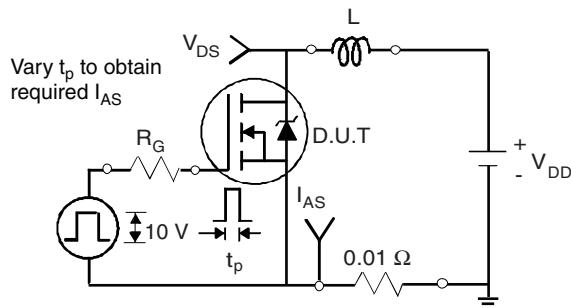


Fig. 14 - Unclamped Inductive Test Circuit

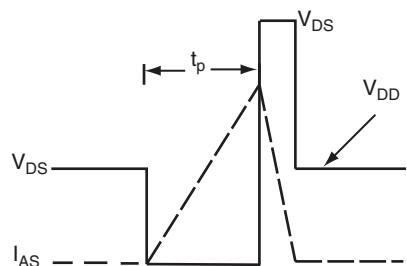


Fig. 15 - Unclamped Inductive Waveforms

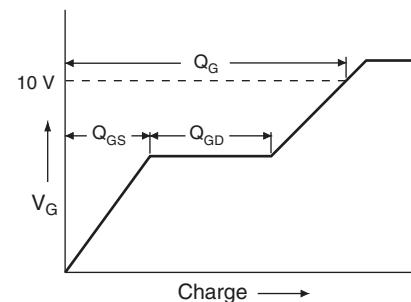


Fig. 16 - Basic Gate Charge Waveform

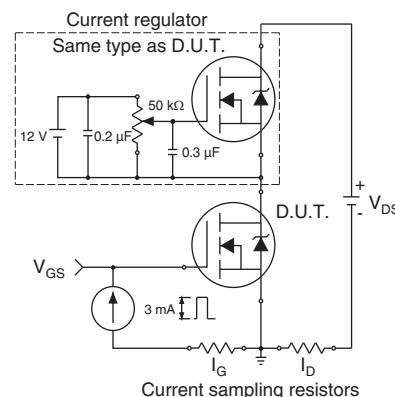
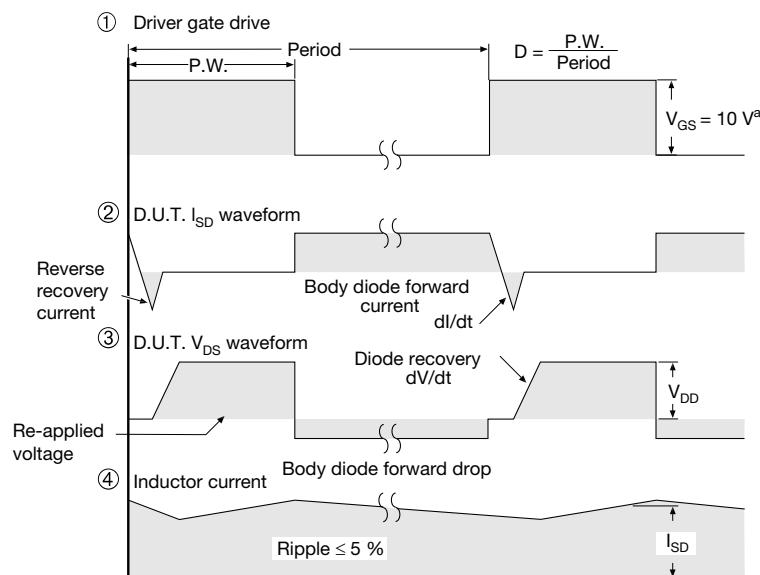
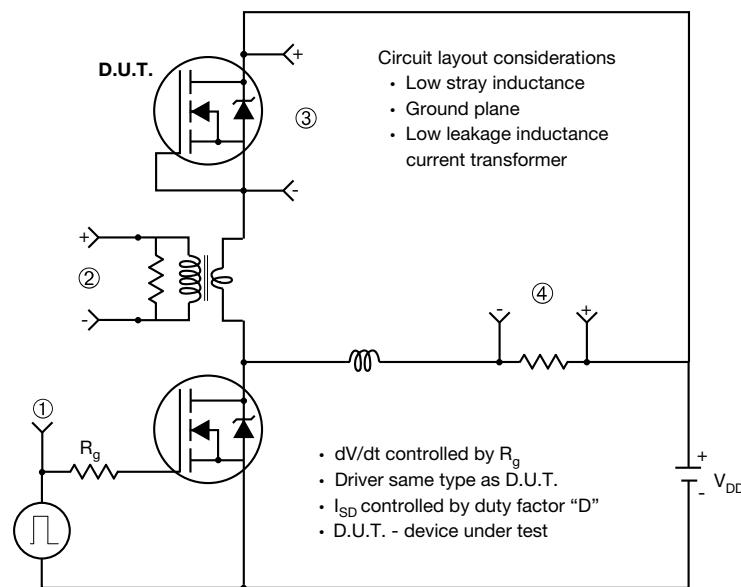


Fig. 17 - Gate Charge Test Circuit

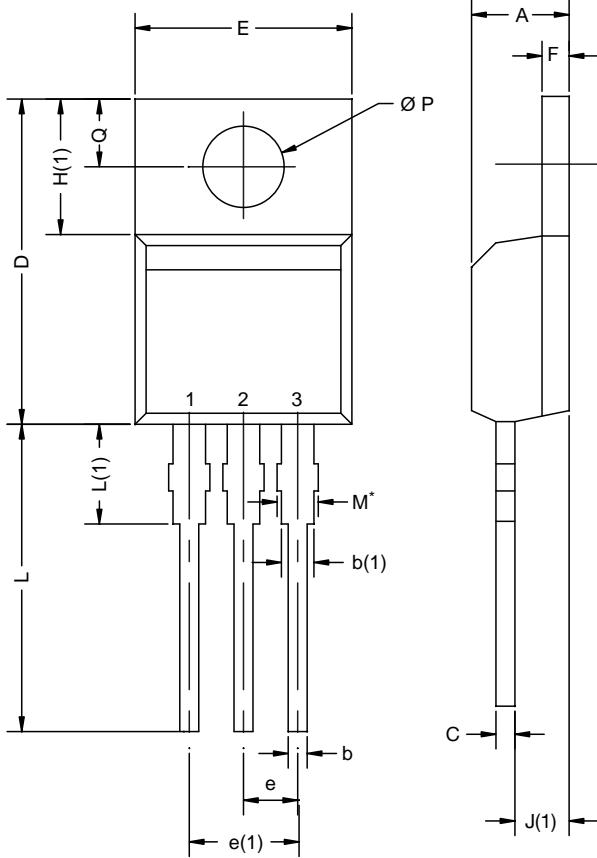
### Peak Diode Recovery dV/dt Test Circuit



**Note**

a.  $V_{GS} = 5 \text{ V}$  for logic level devices

Fig. 18 - For N-Channel

**TO-220AB**

DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
c	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
E	10.04	10.51	0.395	0.414
e	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
Ø P	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118

ECN: X12-0208-Rev. N, 08-Oct-12

DWG: 5471

**Notes**

\* M = 1.32 mm to 1.62 mm (dimension including protrusion)  
 Heatsink hole for HVM

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